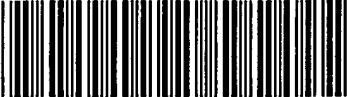


<b>Issue Classification</b> 	Application/Control No.	Applicant(s)/Patent under Reexamination
	09/683,002	BASTIAENS ET AL.
	Examiner Rip A. Lee	Art Unit 1713

ISSUE CLASSIFICATION			
ORIGINAL		CROSS REFERENCE(S)	
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)
525	391	525	92B    92D    88    89
INTERNATIONAL CLASSIFICATION		524	495
C 0 8 L	71/12		
C 0 8 L	53/00		
C 0 8 L	77/00		
	/		
	/		
<i>Rip A. Lee</i> (Assistant Examiner) <i>NOV-19-2005</i> (Date)		<i>David W. Wu</i> DAVID W. WU SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 1700 (Primary Examiner) <i>11/21/05</i> (Date)	Total Claims Allowed: 22
<i>Brinda Jines</i> (Legal Instruments Examiner) <i>11/21/05</i> (Date)		O.G. Print Claim(s) 1	O.G. Print Fig. ---

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
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21	30		60		90		150